

Search Notes

Application/Control No.

10/795,770

Examiner

Tamai I.E. Karl

Applicant(s)/Patent under
Reexamination

HATAKEYAMA ET AL.

Art Unit

2834

SEARCHED

Class	Subclass	Date	Examiner
310	309		
385	18		
359	290,291	2/10/2006	KIT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR